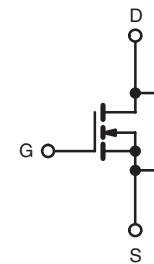
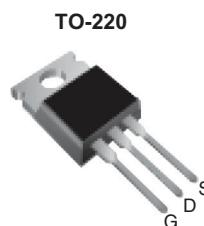


**KERSEMI ELECTRONIC CO.,LTD.**

## Power MOSFET

### FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Fast Switching
- Ease of Parallelizing
- Simple Drive Requirements
- Lead (Pb)-free Available



N-Channel MOSFET

### DESCRIPTION

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.

### PRODUCT SUMMARY

$V_{DS}$ (V)	800	
$R_{DS(on)}$ ( $\Omega$ )	$V_{GS} = 10$ V	3.0
$Q_g$ (Max.) (nC)		78
$Q_{gs}$ (nC)		9.6
$Q_{gd}$ (nC)		45
Configuration		Single

### ORDERING INFORMATION

Package	TO-220
Lead (Pb)-free	IRFBE30PbF SiHFBE30-E3
SnPb	IRFBE30 SiHFBE30

### ABSOLUTE MAXIMUM RATINGS $T_C = 25$ °C, unless otherwise noted

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-Source Voltage	$V_{DS}$	800	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	
Continuous Drain Current	$I_D$	4.1	A
		2.6	
Pulsed Drain Current <sup>a</sup>	$I_{DM}$	16	
Linear Derating Factor		1.0	W/°C
Single Pulse Avalanche Energy <sup>b</sup>	$E_{AS}$	260	mJ
Repetitive Avalanche Current <sup>a</sup>	$I_{AR}$	4.1	A
Repetitive Avalanche Energy <sup>a</sup>	$E_{AR}$	13	mJ
Maximum Power Dissipation	$P_D$	125	W
Peak Diode Recovery dV/dt <sup>c</sup>	dV/dt	2.0	V/ns
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$	- 55 to + 150	°C
Soldering Recommendations (Peak Temperature)	for 10 s	300 <sup>d</sup>	
Mounting Torque	6-32 or M3 screw	10	lbf · in
		1.1	N · m

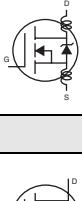
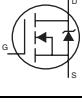
#### Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- $V_{DD} = 50$  V, starting  $T_J = 25$  °C,  $L = 29$  mH,  $R_G = 25 \Omega$ ,  $I_{AS} = 4.1$  A (see fig. 12).
- $I_{SD} \leq 4.1$  A,  $dI/dt \leq 100$  A/ $\mu$ s,  $V_{DD} \leq 600$ ,  $T_J \leq 150$  °C.
- 1.6 mm from case.

**THERMAL RESISTANCE RATINGS**

PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	$R_{thJA}$	-	62	°C/W
Case-to-Sink, Flat, Greased Surface	$R_{thCS}$	0.50	-	
Maximum Junction-to-Case (Drain)	$R_{thJC}$	-	1.0	

**SPECIFICATIONS**  $T_J = 25^\circ\text{C}$ , unless otherwise noted

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
<b>Static</b>							
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}$ , $I_D = 250 \mu\text{A}$	800	-	-	V	
$V_{DS}$ Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference to $25^\circ\text{C}$ , $I_D = 1 \text{ mA}$	-	0.9	-	$\text{V}/^\circ\text{C}$	
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$ , $I_D = 250 \mu\text{A}$	2.0	-	4.0	V	
Gate-Source Leakage	$I_{GSS}$	$V_{GS} = \pm 20 \text{ V}$	-	-	$\pm 100$	nA	
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 800 \text{ V}$ , $V_{GS} = 0 \text{ V}$	-	-	100	$\mu\text{A}$	
		$V_{DS} = 640 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $T_J = 125^\circ\text{C}$	-	-	500		
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = 10 \text{ V}$	$I_D = 2.5 \text{ A}^b$	-	-	$\Omega$	
Forward Transconductance	$g_{fs}$	$V_{DS} = 100 \text{ V}$	$I_D = 2.5 \text{ A}^b$	2.5	-	-	
<b>Dynamic</b>							
Input Capacitance	$C_{iss}$	$V_{GS} = 0 \text{ V}$ , $V_{DS} = 25 \text{ V}$ , $f = 1.0 \text{ MHz}$ , see fig. 5	-	1300	-	pF	
Output Capacitance	$C_{oss}$		-	310	-		
Reverse Transfer Capacitance	$C_{rss}$		-	190	-		
Total Gate Charge	$Q_g$	$V_{GS} = 10 \text{ V}$	$I_D = 4.1 \text{ A}$ , $V_{DS} = 400 \text{ V}$ , see fig. 6 and 13 <sup>b</sup>	-	-	78	
Gate-Source Charge	$Q_{gs}$			-	-	9.6	
Gate-Drain Charge	$Q_{gd}$			-	-	45	
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 400 \text{ V}$ , $I_D = 4.1 \text{ A}$ $R_G = 12 \Omega$ , $R_D = 95 \Omega$ , see fig. 10 <sup>b</sup>	-	12	-	ns	
Rise Time	$t_r$		-	33	-		
Turn-Off Delay Time	$t_{d(off)}$		-	82	-		
Fall Time	$t_f$		-	30	-		
Internal Drain Inductance	$L_D$	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH
Internal Source Inductance	$L_S$			-	7.5	-	
<b>Drain-Source Body Diode Characteristics</b>							
Continuous Source-Drain Diode Current	$I_S$	MOSFET symbol showing the integral reverse p - n junction diode		-	-	4.1	A
Pulsed Diode Forward Current <sup>a</sup>	$I_{SM}$			-	-	16	
Body Diode Voltage	$V_{SD}$	$T_J = 25^\circ\text{C}$ , $I_S = 4.1 \text{ A}$ , $V_{GS} = 0 \text{ V}^b$	-	-	1.8	V	
Body Diode Reverse Recovery Time	$t_{rr}$	$T_J = 25^\circ\text{C}$ , $I_F = 4.1 \text{ A}$ , $dI/dt = 100 \text{ A}/\mu\text{s}^b$	-	480	720	ns	
Body Diode Reverse Recovery Charge	$Q_{rr}$		-	1.8	2.7	$\mu\text{C}$	
Forward Turn-On Time	$t_{on}$	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )					

**Notes**

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width  $\leq 300 \mu\text{s}$ ; duty cycle  $\leq 2\%$ .

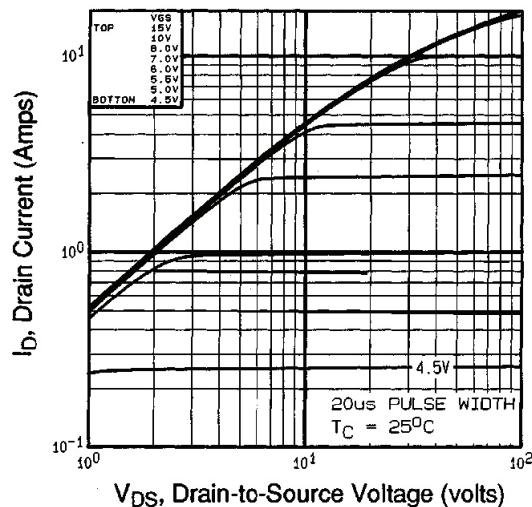
**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted


Fig. 1 - Typical Output Characteristics,  $T_C = 25^\circ\text{C}$

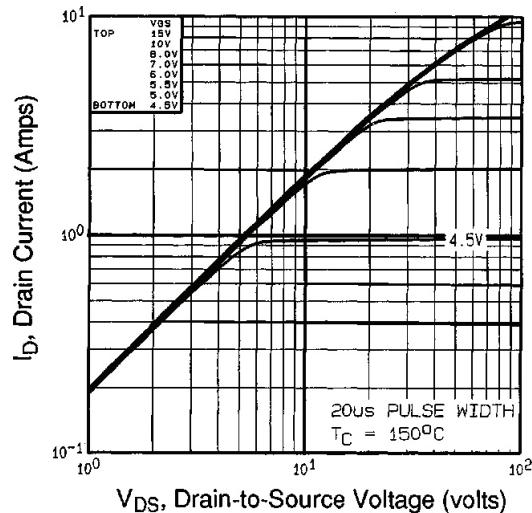
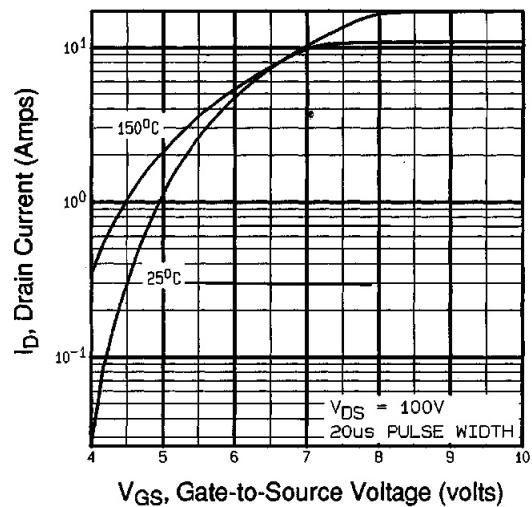
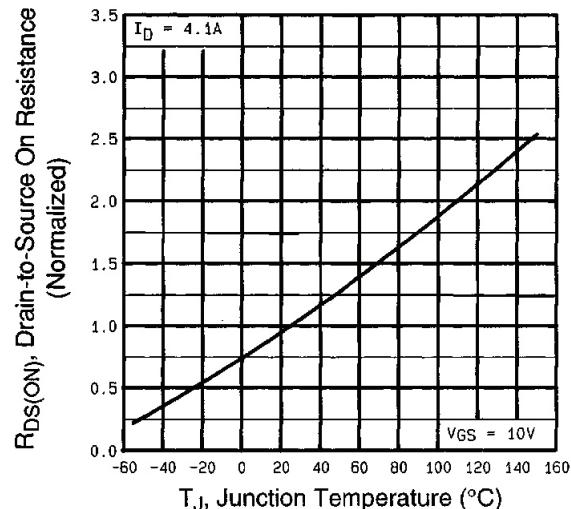


Fig. 2 - Typical Output Characteristics,  $T_C = 150^\circ\text{C}$



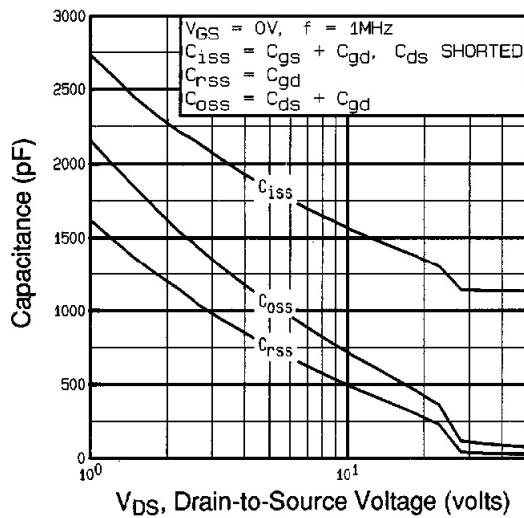


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

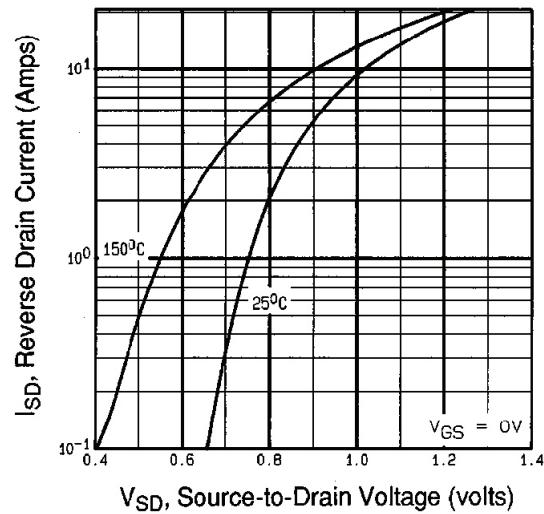


Fig. 7 - Typical Source-Drain Diode Forward Voltage

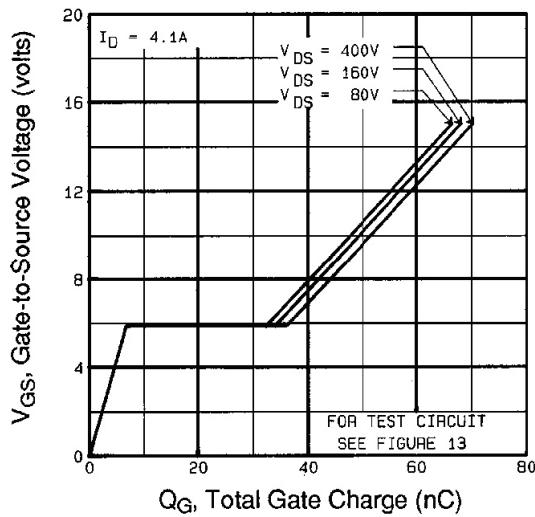


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

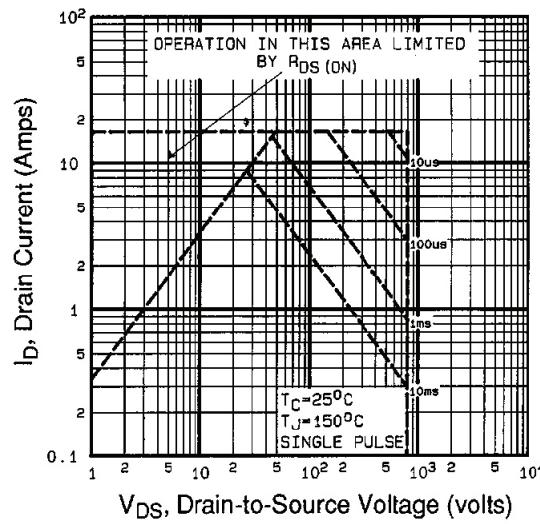


Fig. 8 - Maximum Safe Operating Area

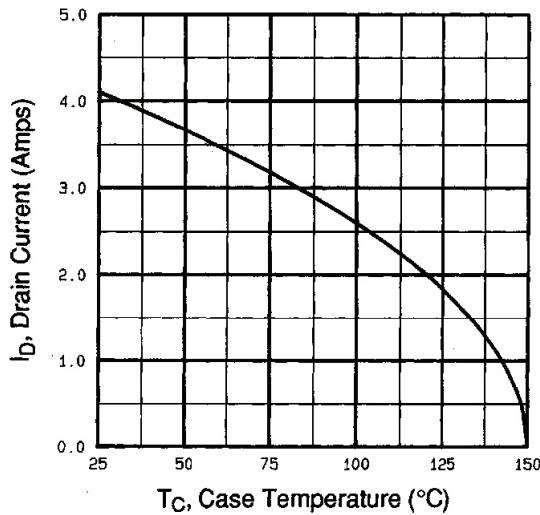


Fig. 9 - Maximum Drain Current vs. Case Temperature

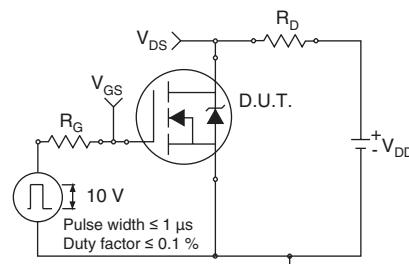


Fig. 10a - Switching Time Test Circuit

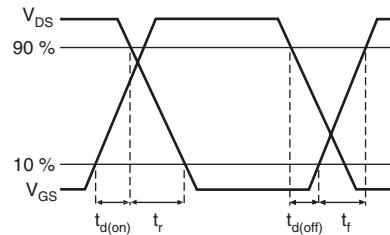


Fig. 10b - Switching Time Waveforms

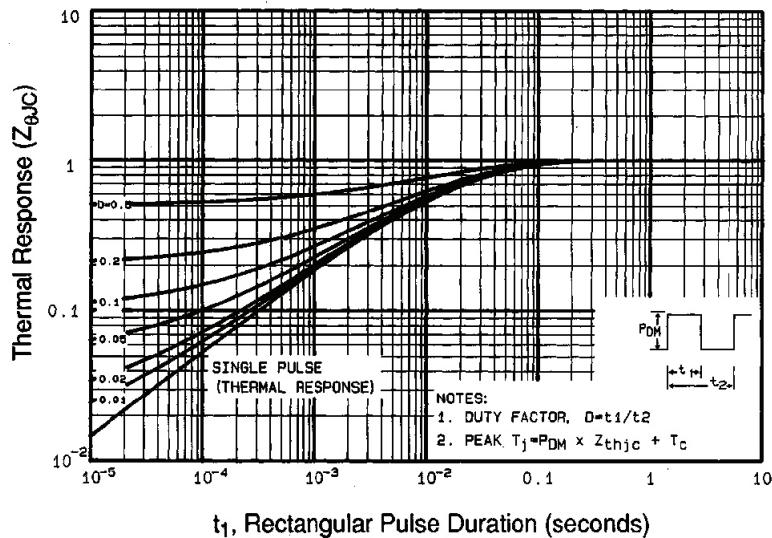


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

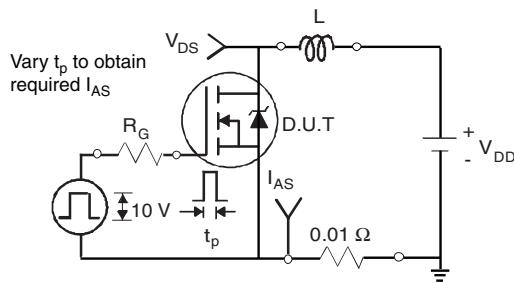


Fig. 12a - Unclamped Inductive Test Circuit

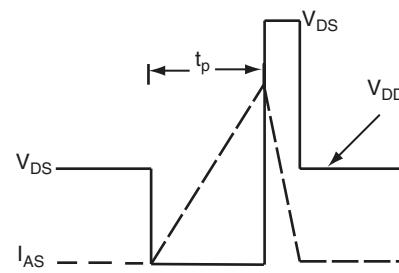


Fig. 12b - Unclamped Inductive Waveforms

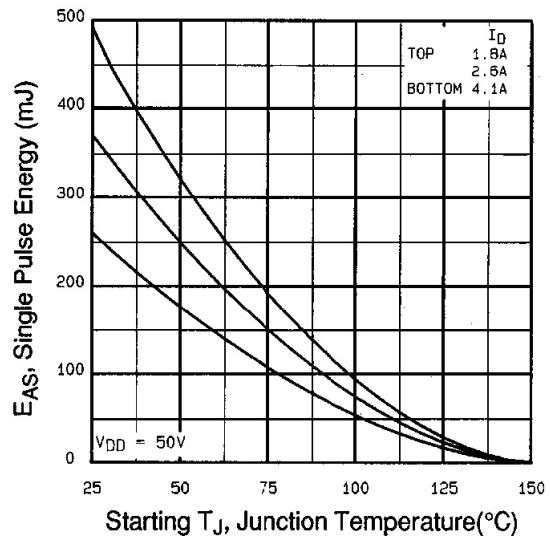


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

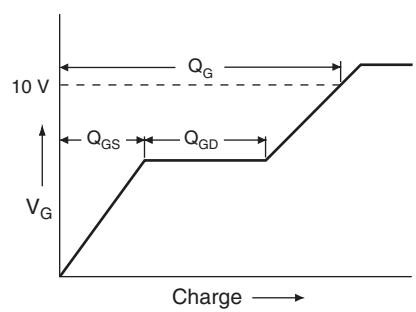


Fig. 13a - Basic Gate Charge Waveform

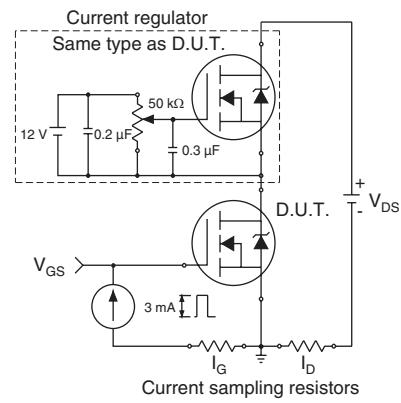
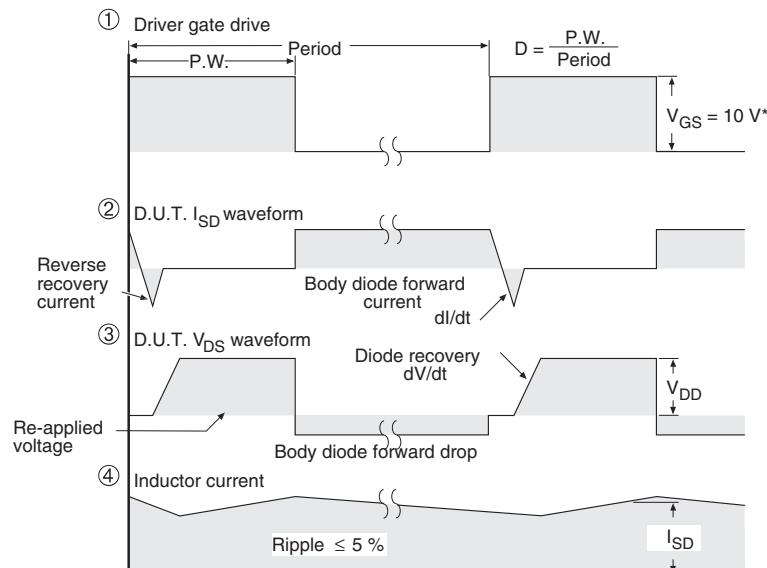
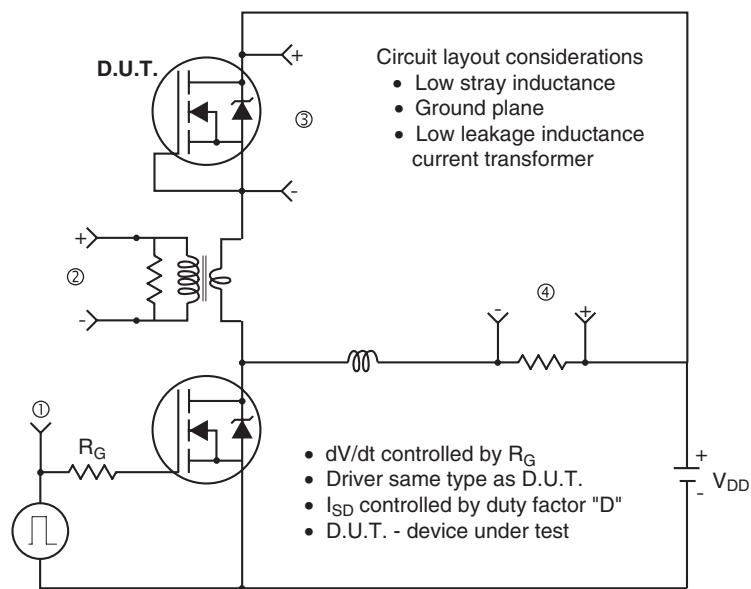


Fig. 13b - Gate Charge Test Circuit

### Peak Diode Recovery dV/dt Test Circuit



\*  $V_{GS} = 5 \text{ V}$  for logic level devices

**Fig. 14 - For N-Channel**